

3D PLUS SPACE MEMORY MODULE P/N DECODER

1	2	3	4	5	6	7	8	9	10	11	12	13
3D <u>XX</u>	<u>000X</u>	<u>00</u>	<u>x</u>	<u>x</u>	<u>0</u>	000	<u>x</u>	<u>x</u>	<u>x</u>	<u>x</u>	<u>00</u>	<u>x</u>

Ex: 3DFN32G08US2845 IS R00M

1 Type

SR: Static RAMPO: PROMFN: Flash NANDSD: Synchronous DRAMEE: EEPROMFO: Flash NOR

 2D: DDR2
 FS: Flash SPI

 3D: DDR3
 MN: MNEMOSYNE

 4D: DDR4
 MR: MRAM

2 Density

nnnK: nnn Kilobit nnnM: nnn Megabit nnnG: nnn Gigabit nnnT: nnn Terabit

Bus width

01: x1 bit **08**: x8 bits **32**: x32 bits **48**: x48 bits **72**: x72 bits **nn**: xnn bits

04: x4 bits **16**: x16 bits **40**: x40 bits **64**: x64 bits **80**: x80 bits

Voltage supply

C: 5.00 V **V**: 3.30 V **S**: 2.80 V **T**: 2.50 V **U**: 1.80 V **W**: 1.50 V **Y**: 1.35 V **L**: 1.20 V

For dual voltage modules, the lowest voltage supply is used.

5 Package

B: BGA **C:** Connector **F:** Flat Pack **J:** QFJ **L:** LGA **P:** PGA

Q: QFP S: SOP

6 <u>Stacked layers</u>

1: 1 layer **2:** 2 layers **4:** 4 layers **8:** 8 layers **A:** 10 layers **n:** n layers

7 Control Features

nnn: Product Flyer or Datasheet number

8 <u>Temperature range</u>

C: +0 °C to +70 °C

I: -40 °C to +85 °C

M: -55 °C to +125 °C

S: Specific

3D PLUS S.A.S. reserves the right to change without notice - 3DPI-0030-11 -Revision 27/11/2023.



9 Screening level

- N: Commercial grade
- B: Industrial grade
- S: Space grade

1 10 Screening and LAT options

- : The Space grade is derived from the ESA Qualified Quality Grade for Space applications (Category 1 hybrid Manufacturer as per ECSS-Q-ST-60-05C).
- 1: The Space grade is derived from the ESA Qualified Quality Grade for Space applications (Category 1 hybrid Manufacturer as per ECSS-Q-ST-60-05C and ECSS-Q-ST-60-13C).
- **P1:** For Space grade modules, screening and qualification flow compliant with PEM-INST-001 Level 1 (for microcircuit plastic encapsulated only). The EEE-INST-002 can be applied as well on demand for other components than microcircuit plastic encapsulated
- **P2:** For Space grade modules, screening and qualification flow compliant with PEM-INST-001 Level 2 (for microcircuit plastic encapsulated only). The EEE-INST-002 can be applied as well on demand for other components than microcircuit plastic encapsulated
- H: Burn-in is performed according to MIL-STD-883 on industrial grade modules
- C: Custom screening as per Custom Product Detail Specification

I 11 Radiation assurance for space grade modules

- A: Generic radiation data available
- R: Specific radiation data tested

Speed/access time

00: N/A	MRAM	FRA	<u>M</u>	DDR1 X X		
	40: 40 ns	60: 60) ns	<u>X</u>	<u>X</u>	
		55: 55	5 ns	5: 200 MHz	C: CL3	
<u>SRAM</u>	SDRAM	DDR2 X X		DDR3 X X		
10: 10 ns	60: 6.0 ns	<u>x</u>	<u>X</u>	<u>X</u>	<u>x</u>	
12: 12 ns	70: 7.0 ns	4: 200 MHz	A: CL =3	H: 667 MHz	9: CL=9	
15: 15 ns	75: 7.5 ns	6: 333 MHz	E: CL =5			

13 Coating, tinning, shielding options

: No option by default

L: SnPb termination

A: "ARATHANE" finish

M: "MAPSIL" finish

T: Tantalum shielding

OVERVIEW

Our Radiation Tolerant SPI NOR Flash are latchup immune, 3.3 V powered memories featuring small pin count and serial interface. They also offer no bad block, high endurance and long time data retention. They are offered in SOP package for high resistance Surface Mount (SMT) assembly and for withstanding harsh thermal and mechanical environments.

This product line is split into two sub-families:

QSPI modules offering high density and high speed (up to 133 MHz) TMR modules offering SEU immunity (due to to the triple modular redundancy) and better TID tolerance through an integrated switch.

First released in 2018, 3D PLUS SPI NOR Flash are used as configuration memory for SRAM-based FPGAs or as boot/program memory for leading processors. These memory modules have been used on missions such as **EMIT** and **others**.

KEY FEATURES







Up to 133	Radiation	Available in
MHz for	tolerance for	all 3D PLUS
QSPI, 50	QSPI	screening
MHz for TMR	modules:	and
modules		qualification
	TID > 20	options:
Small	krad(Si)	
footprint		Commercial
	SEL LET _{th} >	(C)
	62.5	
	MeV.cm²/mg	Industrial (I)
	SEU LET _{th} >	Space
	15.0	qualified (S)
	MeV.cm²/mg;	
	$\sigma_{sat} = 7.5e-11$	
	cm²/bit	







20 years data retention

100, 000 erase/program cycles Radiation tolerance for TMRed modules:

TID > 20 krad (Si) mode ON

> TID > 40 krad(Si) mode OFF

 $SEL LET_{th} > 62.5$ $MeV.cm^{2}/mg$

SEU Immune by TMR

Long life
cycle
products with
proven
reliability in

No pure tin guarantee

Space

Large and worldwide flight heritage



LINE UP

Each 3D PLUS standard product and SiP solution are defined by a specific part number based on the *part number decoder* provided below. The ordering information consist as a minimum of the following 3 items for fully define a product:

The product's Part Number The temperature range The screening level

For High Reliability products or SiPs for Aerospace applications, a Source Control Drawing (SCD#) referenced 3DPA-xxxx is available for each product. It shall be used for its procurement in addition to other ordering information.